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(54) Process for forming a polyimide pattern on a substrate
Verfahren zur Herstellung einer Polyimidstruktur auf einem Träger
Procédé pour la formation d’une texture en polyimide sur un substrat

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(73) Proprietor: International Business Machines Corporation
Armonk, N.Y. 10504 (US)

(72) Inventors:
• Feilchenfeld, Natalie Barbara
Endicott, N.Y. 13 760 (US)
• Fuerniss, Stephen Joseph
Endicott, N.Y. 13 760 (US)

• Glenning, John Joseph
Vestal, N.Y. 13 850 (US)
• Pawlowski, Walter Paul
Endicott, N.Y. 13 760 (US)
• Phelan, Giana Marrone
Endicott, N.Y. 13 760 (US)
• Rickerl, Paul George
Endicott, N.Y. 13 760 (US)

(74) Representative: Schäfer, Wolfgang, Dipl.-Ing.
D-70548 Stuttgart (DE)

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Description

The present invention is concerned with forming polyimide patterns on a substrate and is especially concerned with forming polyimide patterns from a layer of a photosensitive polyimide precursor.

Polyimides are commonly employed in the semiconductor and packaging industry. For instance, in the packaging of semiconductor chips, polyimide films are often coated onto substrates. In a number of these situations it is necessary to form vias in the polyimide layers to allow for electrical connections to be made between different layers of metallurgy. For instance, in the formation of multilayer substrates for mounting chips, one configuration employs an insulating substrate of a ceramic material onto which is deposited a pattern of metallic conductors. Usually, the conductors are three layers of metal, being a layer of chromium, followed by a layer of copper, followed by an overlying layer of chromium. On top of the metallized ceramic substrate is placed a layer or film of a polyimide and on top of the polyimide a second layer of a pattern of conductors is provided.

It is necessary to electrically connect some of the conductors in the upper or second layer of metallization to some of the conductors in the lower or first layer of metallization. In order to do so, the polyimide must be etched to form desired vias therein to allow for a metal connection between the upper and lower layers of the metallization with the pattern of the polyimide being very accurate and of high quality.

Moreover, recent advances in VLSI devices require increased performance from electronic packages. Greater wiring density and smaller signal propagation delay are required to support the high-speed logic chips. Multilayer interconnection technology is an important key to microelectronic packaging. As the volume for multilayer ceramic packages increases, improved methods for manufacturing the substrates have become increasingly important.

For instance, the use of layers of photosensitive polyimide precursors in place of standard polyimides has been suggested, particularly since the procedure employed for the photosensitive layers eliminates a number of steps required when conventional polyimide layers are employed.

It has been observed, however, that when using layers of photosensitive polyimide precursors for applications that require relatively thick films, such as final cure thicknesses of at least about 5 micrometers or more, that the prebaking procedure results in the formation of a white residue on the polyimide type layer. Accordingly, elimination of the formation of white residue would be beneficial.

It is an object of the invention to provide a process for forming polyimide patterns without the formation of a white residue on the polyimide.

It is a further object of the invention to provide a process for forming relatively thick polyimide patterns without the formation of a white residue on the polyimide.

These objects are achieved by a process as disclosed in claim 1.

The particular time/temperature profile is essential in eliminating the problem of white residue formation. The various temperature and time conditions are crucial since applying too little thermal energy to the film results in the formation of the white residue, while applying too much thermal energy, such as heating for too long a period of time or raising the prebake temperature to too high a level, will result in destruction of the photosensitive material and the polyamic acid (polyimide precursor) will imidize and form the polyimide prematurely in the process. If this occurs, it will not be possible to form the necessary vias since this material cannot be removed by the developer solution.

For certain uses of the polyimides and particularly as insulators between different metallized layers on a substrate, it is desirable that the vias exhibit a sidewall profile that is less than about 70° from the horizontal. However, the developing solutions presently employed result in sidewall profiles that approach the vertical and are greater than 70°. In addition, the exposure conditions presently employed result in vias with an overhang lip at the top of the via. The problem with an overhang and with sidewall profiles that are 70° or greater is that the top metal layers which are sputtered on tend to be too thin along the wall of the via due to line-of-sight nature of sputtering (shadow effect which inhibits metal deposition) and during on/off cycling (thermal expansion and contraction) the metal tends to crack, thereby significantly reducing the reliability and life of the vias. Accordingly, it is desirable to control the via size and wall profile thereof.

Two further aspects of the invention take these findings into account:

According to the one of these aspects, the exposure of the film is such as to eliminate the overhang lip at the top of the vias. In particular, smooth sidewall profiles are obtained. The exposure wavelength is preferably 405 to 436 nm and a dose of 150-350 mJ/Cm² measured at the wavelength(s) of irradiation used. The exposed image is then developed.

According to the other of these aspects, the developing is such that sloped wall vias are obtained. In particular, this aspect of the present invention makes it possible to obtain sidewall profiles that are less than 70° from the horizontal. In particular, this aspect of the present invention is concerned with forming a polyimide pattern on a substrate by providing on the substrate a layer of photosensitive polyimide precursor which includes a polyimide precursor and a compound having a photosensitive group. The layer of photosensitive polyimide precursor is prebaked and exposed image-wise to actinic radiation through a photomask to form an exposed image pattern of polyimide precursor in the layer. The unexposed portions of the layer are removed with a liquid developer to provide the sloped sidewall profiles.

Other advantageous embodiments of the inventive process are disclosed in the subclaims.
The inventive process will become more apparent from the following detailed description.

The process of the present invention is concerned with forming a polyimide pattern on a substrate by providing on the substrate a layer of photosensitive polyimide precursor that comprises a polyimide precursor and a compound having a photosensitive group. Photosensitive polyimide precursor compositions are known, as exemplified by U.S. Patent 4,243,743 to Hiramoto, et al. and U.S. Patent 4,547,455 to Hiramoto, et al.

The photosensitive polyimide precursor used can be given the sensitivity to the actinic radiation such as ultraviolet rays, far ultraviolet rays, and visible rays by introducing an organic photosensitive group into the polyimide precursor, for instance the side chain thereof, or by mixing a photosensitive compound with the polyimide precursor. Such photosensitive polyimide precursors are known in the art.

The polyimide precursor is also known in the conventional process of forming the polyimide pattern which is convertible to the polyimide by heating or thermally curing. The typical example of the polyimide precursor is polyamic acid. By the heat-treatment the imide rings are formed in the polymer. The typical heat-treatment is carried out at 135°C, 200°C, 350°C, and 400°C and continued for 30 minutes in each temperature.

The photosensitive group includes those which are dimerized or polymerized by the light to form cross-linkages between the polyimide precursors, those which are activated to radicals or ions by the light, by which radicals or ions the polyimide precursors being cross-linked therebetween, and those which are activated by the light and reacted with the polyimide precursors to reduce the solubility thereof. As such a photosensitive group, a group having carbon-carbon double bond which is dimerizable or polymerizable by the light, an azide group and a quinone diazide group are exemplified.

The photosensitive compound which can be mixed with the polyimide precursor has the photosensitive group mentioned above. As such a photosensitive compound, vinyl compounds having an amino group, bis-azide compounds and naphthoquinone diazide compounds are exemplified.

The following are typical examples of the photosensitive polyimide precursor.

(i) A mixture of a polyimide precursor represented by the formula (II) and a compound having the photosensitive group and amino group:

\[
\text{(II)}
\]

\[
\begin{align*}
\text{OC} & \quad \text{CONH} \\
\text{R}^3 & \quad \text{R}^4 \\
\text{HOOC} & \quad \text{COOH} \\
\text{n} & \quad \text{NH}
\end{align*}
\]

wherein n is an integer and R, and R are tetravalent and bivalent aromatic group, respectively.

The photosensitive group herein mentioned is the same as defined above. Examples of compounds having the photosensitive group and amino group are, allylamine, vinylpyridine, dimethylaminomethyl methacrylate, diethylaminomethyl methacrylate, dimethylaminomethyl acrylate, diethylaminomethyl acrylate, diallylamine, compounds having an azide group and amino group, and compounds having diazide group and amino group.

The group R in the formula (II) includes, for instance, a phenyl, benzophenonyl, naphthyl, and biphenyl group. The group R includes, for instance, phenoxypyphenyl, phenylsulfonilphenyl, benzylphenyl, and phenyl group.

(ii) A polyimide precursor represented by the formula (III):

\[
\text{(III)}
\]

\[
\begin{align*}
\text{OC} & \quad \text{CONH} \\
\text{R}^5 & \quad \text{R}^4 \\
\text{R}^5 & \quad \text{COOH} \\
\text{n} & \quad \text{NH}
\end{align*}
\]

wherein R, R, and n are defined as above, respectively, and R is an organic group having a functional group dimerizable or polymerizable by the light.

The group R includes, for instance, allyl group, methallyl group, and various acylolalkyl groups represented
by the following formulas:

\[
\begin{align*}
\text{R}^6 & \quad \begin{array}{c}
\text{O} \\
- \quad \begin{array}{c}
\text{C} \quad \begin{array}{c}
\text{H} \\
\quad \begin{array}{c}
\text{CH} \quad \text{H}\end{array}
\end{array}
\end{array}
\end{array}
\end{align*}
\]

\[
\begin{align*}
\text{R}^6 & \quad \begin{array}{c}
\text{O} \\
- \quad \begin{array}{c}
\text{C} \\
\quad \begin{array}{c}
\text{CH}\end{array}
\end{array}
\end{array}
\end{align*}
\]

\[
\begin{align*}
\text{R}^6 & \quad \begin{array}{c}
\text{O} \\
- \quad \begin{array}{c}
\text{C} \\
\quad \begin{array}{c}
\text{H} \\
\quad \begin{array}{c}
\text{H}\end{array}
\end{array}
\end{array}
\end{array}
\end{align*}
\]

wherein \( \text{R}^6 \) is bivalent alkylene group of 2 or 3 carbon atoms.

(iii) A polyimide precursor represented by the formula (IV);

\[
\begin{align*}
\begin{array}{c}
\text{OC} \\
\quad \begin{array}{c}
\text{R}^3 \\
\text{CONHOC}
\end{array}
\end{array}
\end{align*}
\]

\[
\begin{align*}
\begin{array}{c}
\text{CONH} \\
\quad \begin{array}{c}
\text{R}^4 \\
\text{CONHCO}^5
\end{array}
\end{array}
\end{align*}
\]

\[
\begin{align*}
\begin{array}{c}
\text{NH} \\
\quad \begin{array}{c}
n
\end{array}
\end{array}
\end{align*}
\]

wherein \( \text{R}^3, \text{R}^4, \text{R}^5, \text{and n} \) are defined as above, respectively.

(iv) A mixture of the polyimide precursor represented by the formula (II) and bis-azide.

(v) A mixture of the polyimide precursor represented by the formula (II) and naphthoquinone diazide.

According to the present invention, the mixture of the polyimide represented by the formula (II) and a compound having the photosensitive group and amino group, which is belonging to type (i), is the most conventional used.

The photosensitive layer may contain one or more photosensitizers such as Michler's ketone, benzoin ether, 2-t-butyl-9-10-anthraquinone, 4,4'-bis(diethylamino)benzophenone, bis-azide compound, monoazide compound, and sulfonamide compound. Further, the photosensitive polyimide precursor may contain a comonomer which is copolymerizable to the polyimide or the precursor thereof.

The photosensitive polyimide precursor compositions are usually applied to the substrate in a form of a solution after being dissolved in a suitable solvent. Conventional solvents include N-methyl-2-pyrrolidone, N,N-dimethylacetamide, -butyrolactone, N,N-dimethylformamide, and preferably N-methyl-2-pyrrolidone.


The photosensitive polyimide precursor composition is coated onto the desired substrate, such as a metallized ceramic substrate, and cured to 40%-60% of initial thickness. When used as the insulator between two layers of metallization, the final thickness is usually 5 to 20 and preferably 8 to 10 μm. The composition is normally sprayed onto the substrate and has a viscosity of 1 to 1.6 Pas (10 to 16 poise) as it is coated.

The layer of the photosensitive polyimide precursor is then prebaked in order to remove the solvent and dry the coating since the most common solvents employed are N-methyl-2-pyrrolidone and -butyrolactone which are sometimes referred to as "slow" solvents or "high boilers" because of their relatively low vapor pressures and are extremely difficult to evaporate. Accordingly, one problem that has existed with respect to removing such solvents and especially the N-methyl-2-pyrrolidone has been the occurrence of a white residue on the polyimide precursor.

With respect to that aspect of the present invention concerned with overcoming this problem, the prebaking procedure involves a judicious selection of temperature/time profile that results in removal of the solvent without imidizing.
the polyamic acid and/or destroying the photoinitiator. In particular, the prebaking, with respect to this aspect of the present invention, involves placing the layer in an oven and ramping up the temperature of the oven to 90°C, preferably at a rate of 6°C/minute and maintaining at that temperature for up to 2 minutes and preferably 15 seconds to 2 minutes. Also, it is preferred that prior to the ramping up of the temperature to 90°C, the oven is at 60°C for 10 minutes. Then the temperature is ramped down to 60°C, preferably at a rate of 1°C/minute and maintained at 60°C for 90 to 150 minutes; after which, it is cooled down to at least 60°C and preferably cooled down at a rate of 2 to 4°C/minute. In particular, the faster the cooling down to the 60°C, the better.

By following this particular prebake profile, the problem with respect to formation of white residue is eliminated.

After the prebaking, the layer is exposed imagnewise to actinic radiation through a photomask to form an exposed image pattern of polyimide precursor in the layer.

The actinic radiation can, for example, be provided by employing a high pressure mercury lamp which has optics that have been optimized for a single wavelength. The commonly used wavelengths are 365 nm to 436 nm, preferably 405 nm to 436 nm, including 365 nm, 405 nm, and 436 nm. The most preferred wavelength employed pursuant to the present invention is 365 nm. The exposure energies employed in accordance with the present invention are usually 150 mj/cm² to 350 mj/cm² as measured at the wavelength(s) of irradiation. The preferred exposure energies employed are 250 to 350 mj/cm².

The use of the preferred exposure conditions provide for exposing the polyimide more uniformly throughout the film thickness to provide the sloped wall vias.

This is so despite the relatively low transmission of light through the film.

After the exposure through a photomask, the mask is removed and the exposed photosensitive layer is developed.

Examples of photomasks include chromium mask bearing an image pattern of chromium or chromium oxide on a glass or an emulsion mask bearing the image pattern of photographic emulsion on the glass or a transparent film.

With respect to those aspects of the present invention where it is desired to provide sidewall profiles of the vias that are less than 70° from the horizontal and preferably 45° from the horizontal, a developing solution, as discussed below, must be employed. Sidewall profiles less than 70° from the horizontal are desired when employing relatively thick polyimide layers that are used to insulate two metallization layers from each other. In particular, if the wall profile is greater than 70°, the second metallization layers that are sputtered on will be too thin along the wall of the vias and during on/off cycling (thermal expansion and contraction), the metal will tend to crack, thereby significantly decreasing the reliability and life of the vias.

It has been found, pursuant to the present invention, that the sloped wall vias of the type desired can be obtained by employing a solvent solution that contains 50% to 75% by volume of N-methyl-2-pyrrolidone, 5% to 10% by volume of water, 1% to 4% by volume of isopropyl alcohol, and 15% to 40% by volume of methyl alcohol. A typical example of a developing solution within the context of the present invention contains 62.3% by volume of N-methyl-2-pyrrolidone, 8.9% by volume of water, 2.7% by volume of isopropyl alcohol, and 26.1% by volume of methyl alcohol.

The relative amounts of these materials are crucial to obtaining the desired result. For instance, if greater than 10% by volume of water is employed, an undesirable side reaction occurs, thereby producing white residue. In addition, if greater than 4% by volume of isopropyl alcohol is employed, the developer will not adequately form the necessary vias. The isopropyl alcohol tends to decrease the penetration of the developer solution but, at the same time, decreasing the reaction rate. Accordingly, it was necessary to employ the water in order to provide a sufficient developing rate.

The temperature of the developing is usually from 20°C to 30°C controlled to ± 1°C. Also, the developing mixture results in reduced edge attack of the film. Edge attack is when the polyimide is stripped off along an area that is laterally exposed to the developer composition. Furthermore, the use of the developer compositions employed pursuant to the present invention provide more consistent via sizes than previously experienced. For instance, deviations of only 3.3 μm (0.13 mils) over the bottom diameter and standard deviation of the top diameter of less than the bottom diameter of 2.03 μm (0.08 mils) has been observed.

After developing, the exposed image pattern of the polyimide precursor in the layer is cured by convection heating, such as at temperatures of 350°C to 400°C for 30 to 90 minutes. Normally, the crosslinked photosensitive polyimide precursor is heated to 350°C to 400°C for at least 30 minutes in a convection oven under a nitrogen atmosphere for final curing.

The following non-limiting example is presented to further illustrate the present invention:

**EXAMPLE**

Toray UR-3640 photosensitive polyimide is spray applied onto a ceramic base with a chromium-copper-chromium metallurgy imaged into a circuit pattern by photolithographic operations. This photosensitive polyimide is spray applied to an initial thickness of 25 microns. The parts are then subjected to a 60°C bake for 10 minutes followed by a ramp up to 90°C at a rate of 8°C per minute. The temperature is then ramped down to 80°C at a rate of 1°C per minute. The parts remain at this temperature for 2 hours. The temperature in the oven is then cooled down to 60°C and the parts
are then removed. The parts are then exposed with a pattern at 405 nanometers (wavelength of light) with an exposure energy of 250 millijoules per square centimeter.

The image exposed is then developed in a developer solution containing 60% N-Methyl-2-Pyrrolidone, 5% water, 3% isopropyl alcohol with the balance methyl alcohol (% is by volume) at 30°C for 6 minutes with ultrasonic agitation and movement of the parts (to prevent a standing wave effect). The parts are then rinsed in isopropyl alcohol at room temperature for 10 minutes and then air dried.

The parts are then subjected to 350°C for 30 minutes to complete the cure and harden the image.

Claims

1. Process of forming a polyimide pattern on a substrate which comprises:
   a) providing on the substrate a layer of photosensitive polyimide precursor comprising a polyimide precursor and a compound having a photosensitive group;
   b) prebaking the layer of photosensitive polyimide precursor by placing the layer in an oven and ramping up the temperature of the oven to 90°C and maintaining at 90°C for up to 2 minutes, then ramping down to 80°C and maintaining 80°C for 90 minutes to 150 minutes and cooling down to at least 60°C;
   c) exposing said layer imagewise to actinic radiation through a photomask to form an exposed image pattern of polyimide precursor in the layer;
   d) removing unexposed areas of the layer with a liquid developer; and
   e) curing the exposed image pattern of the polyimide precursor in the layer by heating.

2. Process according to claim 1 wherein said liquid developer contains 50-75% by volume of N-methyl-2-pyrrolidone; 5-10% by volume of water; 1-4% by volume of isopropyl alcohol; and 15-40% by volume of methyl alcohol.

3. Process according to claim 1 or 2 wherein the temperature is maintained at 90°C for 15 seconds to 2 minutes.

4. Process according to any one of claims 1 to 3 wherein the oven is at a temperature of 60°C for 10 minutes prior to the ramping up to 90°C and wherein said ramping is at a rate of 6°C/minute with the ramping down to 80°C being preferably at a rate of 1°C/minute.

5. Process according to any one of claims 1 to 4 wherein the layer is cooled down to at least 60°C at a rate of 2°C/minute to 4°C/minute.

6. Process according to any one of claims 1 to 5 wherein the polyimide precursor composition is applied as a solution in N-methyl-2-pyrrolidone with the viscosity of the solution being preferably between 1 and 1.6 Pas (10 and 16 poise).

7. Process according to any one of claims 1 to 6 wherein the final thickness of the layer of photosensitive polyimide is 5 to 20 μm with 8 to 10 μm being preferred.

8. Process according to any one of claims 1 to 7 wherein said layer is exposed to actinic radiation having a wavelength of 365 nm to 436 nm at an energy level of 150 to 350 mj/cm² with said radiation having preferably a wavelength of 436 nm and said energy level being preferably 250 to 350 mj/cm².

9. Process according to any one of claims 1 to 8 wherein said developer contains 62.3% by volume of N-methyl-2-pyrrolidone; 8.9% by volume of water; 2.7% by volume of isopropyl alcohol; and 26.1% by volume of methyl alcohol.

Patentansprüche

1. Verfahren zur Herstellung einer Polyimidstruktur auf einem Substrat, das umfaßt:
EP 0 342 393 B1

a) Bereitstellen einer Schicht aus einer lichtempfindlichen Polyimidvorstufe auf dem Substrat, die eine Polyimidvorstufe und eine Verbindung mit einer lichtempfindlichen Gruppe umfaßt;

b) Vorbrennen der Schicht aus einer lichtempfindlichen Polyimidvorstufe durch Plazieren der Schicht in einem Ofen, wobei die Ofentemperatur auf 90 °C erhöht und während bis zu 2 Minuten bei 90 °C gehalten wird, anschließendes Absenken auf 80 °C und während 90 Minuten bis 150 Minuten Halten auf 80 °C sowie Abkühlen auf mindestens 60 °C;

c) bildweises Belichten der Schicht mit einer aktinischen Strahlung durch eine Fotomaske, um ein belichtetes Bildmuster der Polyimidvorstufe in der Schicht zu erzeugen;

d) Entfernen der unbelichteten Bereiche der Schicht mit einem Flüssigentwickler, und

e) Härten des belichteten Bildmusters der Polyimidvorstufe in der Schicht durch Erwärmen.

2. Verfahren gemäß Anspruch 1, wobei der Flüssigentwickler 50 Volumenprozent bis 75 Volumenprozent N-Methyl-2-Pyrrolidon; 5 Volumenprozent bis 10 Volumenprozent Wasser; 1 Volumenprozent bis 4 Volumenprozent Isopropylalkohol; und 15 Volumenprozent bis 40 Volumenprozent Methylalkohol enthält.

3. Verfahren nach Anspruch 1 oder 2, wobei die Temperatur während 15 Sekunden bis 2 Minuten bei 90 °C gehalten wird.

4. Verfahren gemäß irgendeinem der Ansprüche 1 bis 3, wobei der Ofen vor der Temperaturerhöhung auf 90 °C während 10 Minuten bei einer Temperatur von 60 °C gehalten wird, und wobei die Temperaturerhöhung mit einer Geschwindigkeit von 6 °C/Minute und die Temperaturabsenkung auf 80 °C bevorzugt mit einer Geschwindigkeit von 1 °C/Minute erfolgen.

5. Verfahren nach einem der Ansprüche 1 bis 4, wobei die Schicht mit einer Geschwindigkeit zwischen 2 °C/Minute und 4 °C/Minute auf mindestens 60 °C abgekühlt wird.

6. Verfahren nach einem der Ansprüche 1 bis 5, wobei die Zusammensetzung mit der Polyimidvorstufe als eine Lösung in N-Methyl-2-Pyrrolidon angewendet wird, wobei die Viskosität der Lösung bevorzugt zwischen 1 Pas und 1,6 Pas (10 Poise und 16 Poise) beträgt.

7. Verfahren nach einem der Ansprüche 1 bis 6, wobei die abschließende Dicke der Schicht aus lichtempfindlichem Polyimid zwischen 5 μm und 20 μm und bevorzugt zwischen 8 μm und 10 μm beträgt.

8. Verfahren nach einem der Ansprüche 1 bis 7, wobei die Schicht mit einer aktinischen Strahlung mit einer Wellenlänge zwischen 365 nm und 436 nm und einem Energieniveau zwischen 150 mJ/cm² und 350 mJ/cm² belichtet wird, und wobei die Strahlung bevorzugt eine Wellenlänge von 436 nm und bevorzugt ein Energieniveau von 250 mJ/cm² bis 350 mJ/cm² hat.

9. Verfahren nach einem der Ansprüche 1 bis 8, wobei der Entwickler 62,3 Volumenprozent N-Methyl-2-Pyrrolidon; 8,9 Volumenprozent Wasser; 2,7 Volumenprozent Isopropylalkohol; und 26,1 Volumenprozent Methylalkohol enthält.

Revendications

1. Procédé pour la formation d'un motif en polyimide sur un substrat, comprenant :

   a) réalisation sur le substrat d'une couche de précurseur polyimide photosensible comprenant un précurseur polyimide et un composé ayant un groupe photosensible ;

   b) pré-cuisson de la couche de précurseur en polyimide photosensible, par introduction de la couche dans un four et augmentation de la température du four jusqu'à 90°C et maintien à la température de 90°C pendant une durée allant jusqu'à 2 minutes, puis descente de la température jusqu'à 80°C et maintien à la température de 80°C pendant 90 minutes à 150 minutes et refroidissement jusqu'à au moins 60°C ;

7
c) exposition de ladite couche formant image à un rayonnement actinique, par l'intermédiaire d'un photomask pour constituer une technique d'image exposée de précurseur polyimide dans la couche ;
d) enlèvement des zones non exposées de la couche avec un révélateur liquide ; et
e) traitement-polymérisation du motif formant image exposé de précurseur polyimide dans la couche, par chauffage.

2. Procédé selon la revendication 1, dans lequel ledit révélateur liquide contient de 50 à 75 % en volume de N-méthyl-2-pyrrolidon ; de 5 à 10 % volume d'eau ; de 1 à 4 % volume d'alcool isopropylique et de 15 à 40 % en volume d'alcool méthyle.

3. Procédé selon la revendication 1 ou 2, dans lequel la température est maintenue à 90°C pendant 15 secondes à 2 minutes.

4. Procédé selon l'une des revendications 1 à 3, dans lequel le four est placé à une température de 60°C pendant 10 minutes avant le chauffage à 90°C dans lequel ladite augmentation de température se fait à une vitesse de 6°C/minute et la diminution de température jusqu'à 80°C se faisant de préférence à une vitesse de 1°C/minute.

5. Traitement selon l'une quelconque des revendications 1 à 4, dans lequel la couche est refroidie jusqu'à au moins 60°C à une vitesse de 2°C/minute à 4°C/minute.

6. Procédé selon l'une quelconque des revendications 1 à 5, dans lequel la composition du précurseur polyimide est appliquée sous forme de solution dans le N-méthyl-2-pyrrolidon, la viscosité de la solution étant de préférence comprise entre 1 et 1,6 Pas (10 et 16 poiss).

7. Procédé selon l'une des revendications 1 à 6, dans lequel l'épaisseur finale de la couche de polyimide photosensible est de 5 à 20 μm, de préférence de 8 à 10 μm.

8. Procédé selon l'une quelconque des revendications 1 à 7, dans lequel ladite couche est exposée à un rayonnement actinique ayant une longueur d'onde de 365 nm à 436 nm, à un niveau d'énergie de 150 à 350 mJ/cm², ledit rayonnement ayant de préférence une longueur d'onde de 436 nm et ledit niveau d'énergie étant de préférence de 250 à 350 mJ/cm².

9. Procédé selon l'une quelconque des revendications 1 à 7, dans lequel ledit révélateur contient 62,3 % en volume de N-méthyl-2-pyrrolidon ; 8,9 % en volume d'eau ; 2,7 % en volume d'alcool isopropylique ; et 26,1 % en volume d'alcool méthyle.